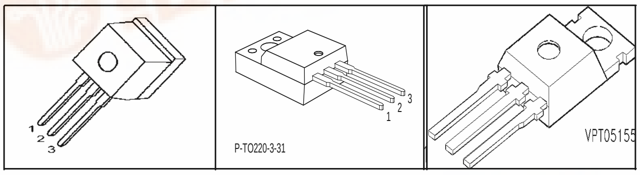
Cool MOS™ Power Transistor

V_{DS} @ T_{jmax}	650	V
$R_{DS(on)}$	0.19	Ω
I_D	20.7	A

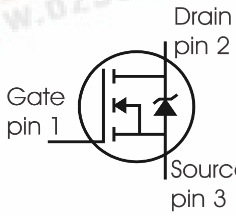
Feature

- New revolutionary high voltage technology
- Worldwide best $R_{DS(on)}$ in TO 220
- Ultra low gate charge
- Periodic avalanche rated
- Extreme dv/dt rated
- High peak current capability
- Improved transconductance

P-TO262-3-1 P-TO220-3-31 P-TO220-3-1



Type	Package	Ordering Code	Marking
SPP20N65C3	P-TO220-3-1	Q67040-S4556	20N65C3
SPA20N65C3	P-TO220-3-31	Q67040-S4555	20N65C3
SPI20N65C3	P-TO262-3-1	Q67040-S4560	20N65C3



Maximum Ratings

Parameter	Symbol	Value		Unit
		SPP_I	SPA	
Continuous drain current	I_D			A
T_C = 25 °C		20.7	20.7[1)]	
T_C = 100 °C		13.1	13.1[1)]	
Pulsed drain current, t_p limited by T_{jmax}	$I_{D\ puls}$	62.1	62.1	A
Avalanche energy, single pulse I_D=3.5A, V_{DD}=50V	E_{AS}	690	690	mJ
Avalanche energy, repetitive t_{AR} limited by T_{jmax}[2)] I_D=7A, V_{DD}=50V	E_{AR}	1	1	
Avalanche current, repetitive t_{AR} limited by T_{jmax}	I_{AR}	7	7	A
Gate source voltage	V_{GS}	±20	±20	V
Gate source voltage AC (f >1Hz)	V_{GS}	±30	±30	
Power dissipation, T_C = 25°C	P_{tot}	208	34.5	W
Operating and storage temperature	T_j , T_{stg}	-55...+150		°C

Maximum Ratings

Parameter	Symbol	Value	Unit
Drain Source voltage slope V_{DS} = 480 V, I_D = 20.7 A, T_j = 125 °C	d*v*/d*t*	50	V/ns

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Thermal resistance, junction - case	R_{thJC}	-	-	0.6	K/W
Thermal resistance, junction - case, FullPAK	R_{thJC_FP}	-	-	3.6	
Thermal resistance, junction - ambient, leaded	R_{thJA}	-	-	62	
Thermal resistance, junction - ambient, FullPAK	R_{thJA_FP}	-	-	80	
SMD version, device on PCB:	R_{thJA}				
@ min. footprint		-	-	62	
@ 6 cm² cooling area [3)]		-	35	-	
Soldering temperature, 1.6 mm (0.063 in.) from case for 10s [4)]	T_{sold}	-	-	260	°C

Electrical Characteristics, at T_j=25°C unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0V, I_D=0.25mA	650 [5)]	-	-	V
Drain-Source avalanche breakdown voltage	$V_{(BR)DS}$	V_{GS}=0V, I_D=7A	-	730	-	
Gate threshold voltage	$V_{GS(th)}$	I_D=1000µA, V_{GS}=V_{DS}	2.1	3	3.9	
Zero gate voltage drain current	I_{DSS}	V_{DS}=600V, V_{GS}=0V,				µA
		T_j=25°C	-	0.1	1	
		T_j=150°C	-	-	100	
Gate-source leakage current	I_{GSS}	V_{GS}=20V, V_{DS}=0V	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=10V, I_D=13.1A				Ω
		T_j=25°C	-	0.16	0.19	
		T_j=150°C	-	0.43	-	
Gate input resistance	R_G	*f*=1MHz, open drain	-	0.54	-	

Electrical Characteristics

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Transconductance	g_{fs}	$V_{DS} \geq 2 * I_D * R_{DS(on)max}$, I_D=13.1A	-	17.5	-	S
Input capacitance	C_{iss}	V_{GS}=0V, V_{DS}=25V, f=1MHz	-	2400	-	pF
Output capacitance	C_{oss}		-	780	-	
Reverse transfer capacitance	C_{rss}		-	50	-	
Effective output capacitance,[6] energy related	$C_{o(er)}$	V_{GS}=0V, V_{DS}=0V to 480V	-	83	-	
Effective output capacitance,[7] time related	$C_{o(tr)}$		-	160	-	
Turn-on delay time	$t_{d(on)}$	V_{DD}=380V, V_{GS}=0/13V, I_D=20.7A, R_G=3.6Ω, T_j=125	-	10	-	ns
Rise time	t_r	V_{DD}=380V, V_{GS}=0/13V, I_D=20.7A, R_G=3.6Ω	-	5	-	
Turn-off delay time	$t_{d(off)}$		-	67	100	
Fall time	t_f		-	4.5	12	

Gate Charge Characteristics

Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Gate to source charge	Q_{gs}	V_{DD}=480V, I_D=20.7A	-	11	-	nC
Gate to drain charge	Q_{gd}		-	33	-	
Gate charge total	Q_g	V_{DD}=480V, I_D=20.7A, V_{GS}=0 to 10V	-	87	114	
Gate plateau voltage	$V_{(plateau)}$	V_{DD}=480V, I_D=20.7A	-	5.5	-	V

[1] Limited only by maximum temperature

[2] Repetitve avalanche causes additional power losses that can be calculated as $P_{AV}=E_{AR}*f$.

[3] Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

[4] Soldering temperature for TO-263: 220°C, reflow

[5] HTRB @ 1000h, 600V, T_{jmax} resp. accelerated HTRB @ 168h, 600V, T_j= 175°C
according to JEDEC A108, MIL-STD 750/1038-1040, 1042

[6] $C_{o(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

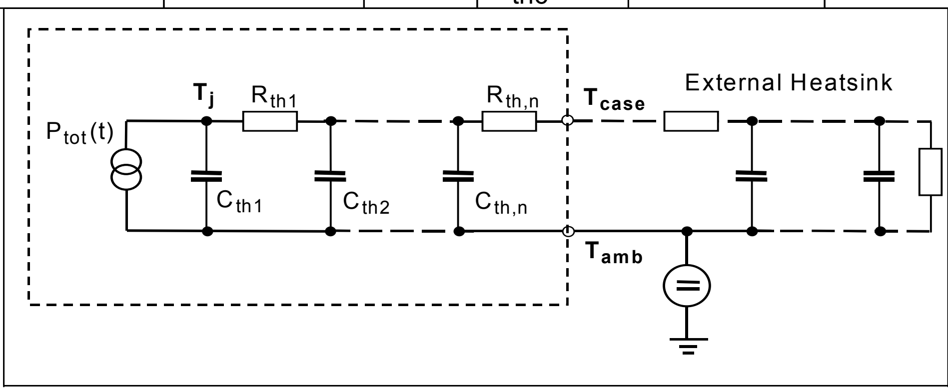
[7] $C_{o(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

Electrical Characteristics

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Inverse diode continuous forward current	I_S	T_C=25°C	-	-	20.7	A
Inverse diode direct current, pulsed	I_{SM}		-	-	62.1	
Inverse diode forward voltage	V_{SD}	V_{GS}=0V, I_F=I_S	-	1	1.2	V
Reverse recovery time	t_{rr}	V_R=480V, I_F=I_S , di_F/dt=100A/µs	-	500	800	ns
Reverse recovery charge	Q_{rr}		-	11	-	µC
Peak reverse recovery current	I_{rrm}		-	70	-	A
Peak rate of fall of reverse recovery current	di_{rr}/dt	T_j=25°C	-	1400	-	A/µs

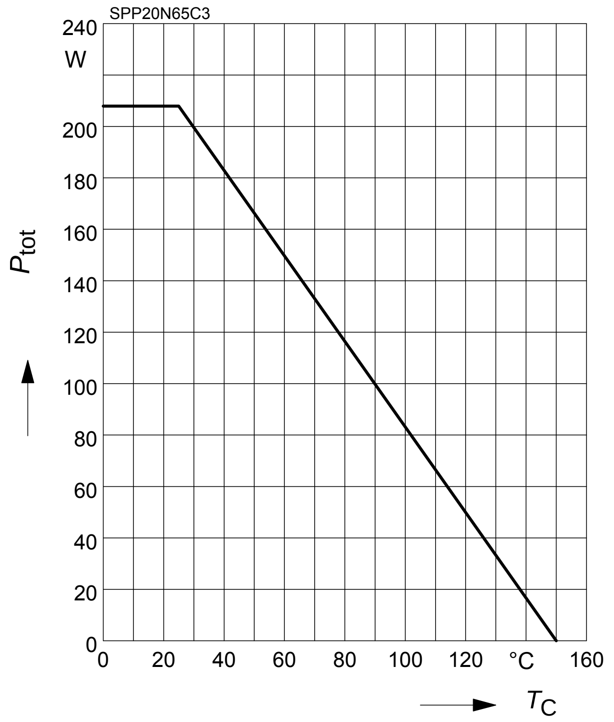
Typical Transient Thermal Characteristics

Symbol	Value		Unit	Symbol	Value		Unit
	SPP_B	SPA			SPP_B	SPA	
R_{th1}	0.00769	0.00769	K/W	C_{th1}	0.0003763	0.0003763	Ws/K
R_{th2}	0.015	0.015		C_{th2}	0.001411	0.001411	
R_{th3}	0.029	0.029		C_{th3}	0.001931	0.001931	
R_{th4}	0.114	0.163		C_{th4}	0.005297	0.005297	
R_{th5}	0.136	0.323		C_{th5}	0.012	0.008453	
R_{th6}	0.059	2.526		C_{th6}	0.091	0.412	



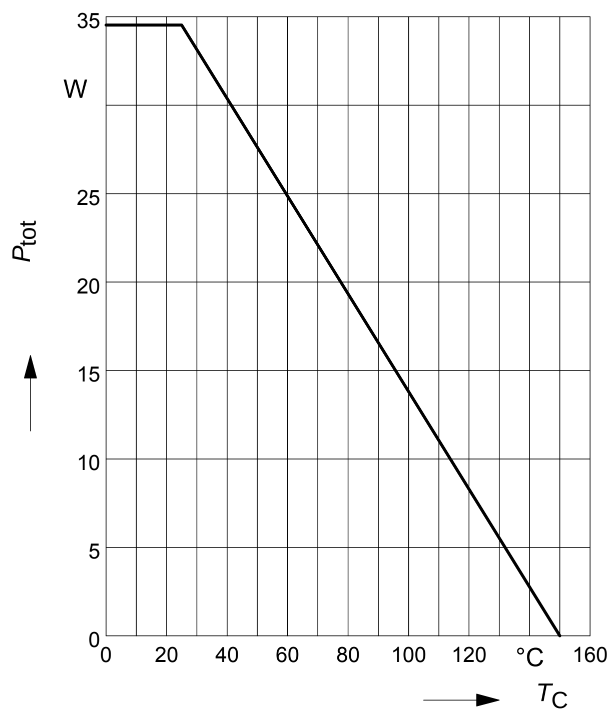
1 Power dissipation

$P_{tot} = f(T_C)$



2 Power dissipation FullPAK

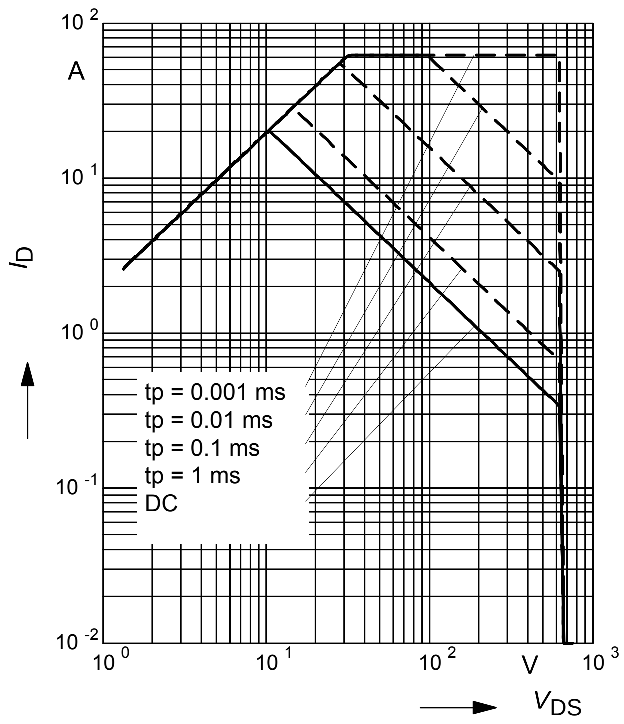
$P_{tot} = f(T_C)$



3 Safe operating area

$I_D = f(V_{DS})$

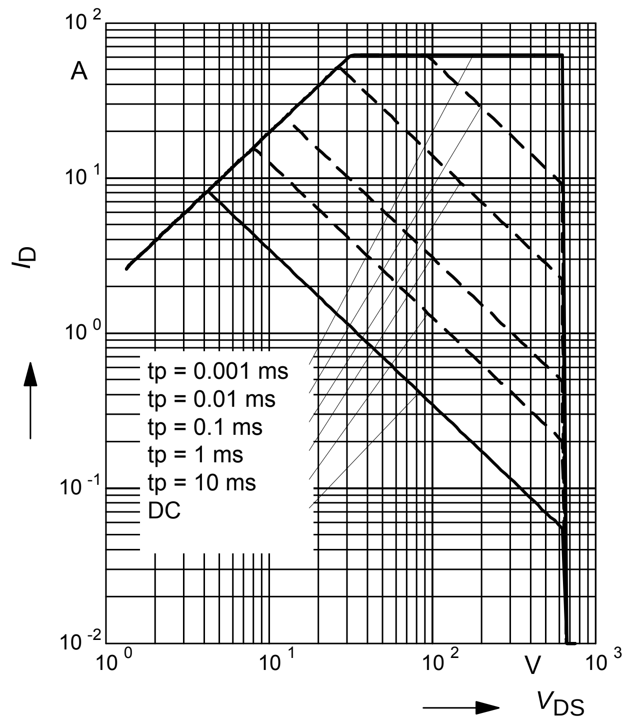
parameter : $D = 0$, T_C=25°C



4 Safe operating area FullPAK

$I_D = f(V_{DS})$

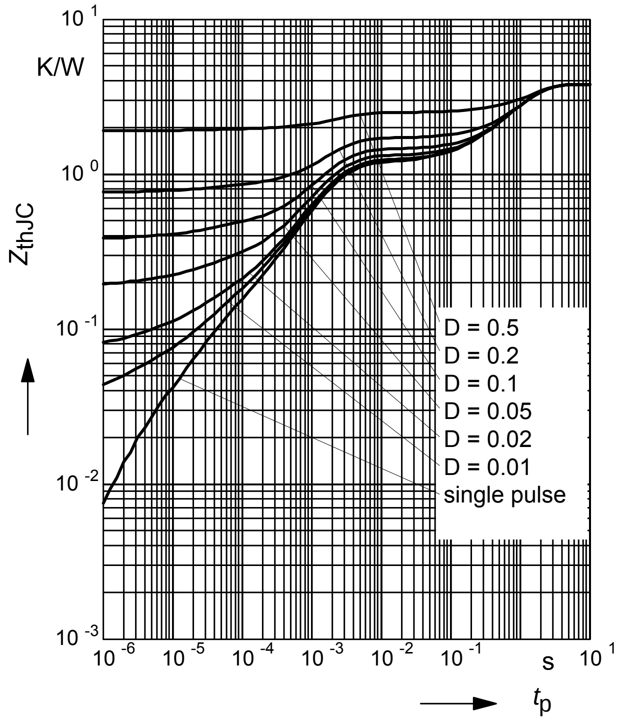
parameter: $D = 0$, T_C = 25°C



5 Transient thermal impedance FullPAK

$Z_{thJC} = f(t_p)$

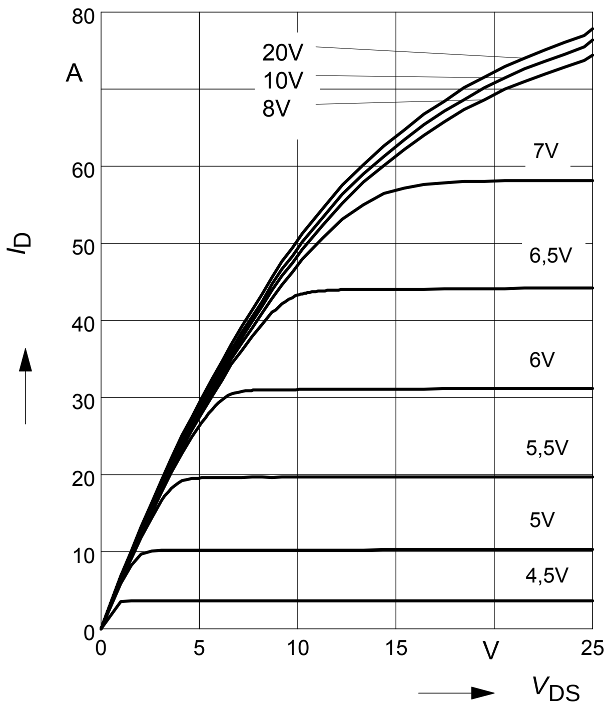
parameter: $D = t_p/t$



6 Typ. output characteristic

$I_D = f(V_{DS})$; T_j=25°C

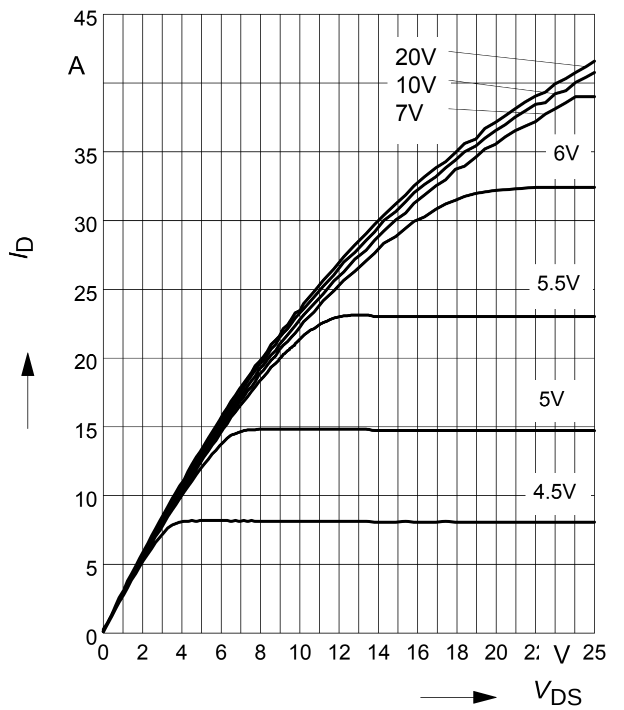
parameter: t_p = 10 µs, V_{GS}



7 Typ. output characteristic

$I_D = f(V_{DS})$; T_j=150°C

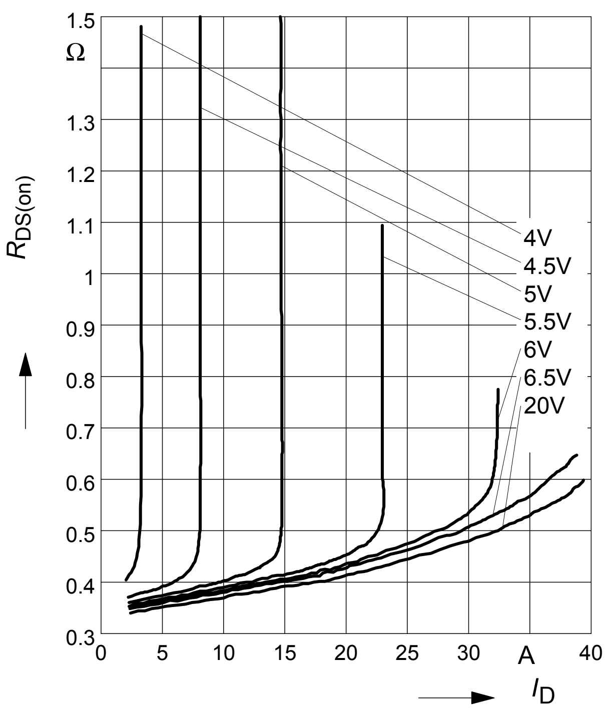
parameter: t_p = 10 µs, V_{GS}



8 Typ. drain-source on resistance

$R_{DS(on)}=f(I_D)$

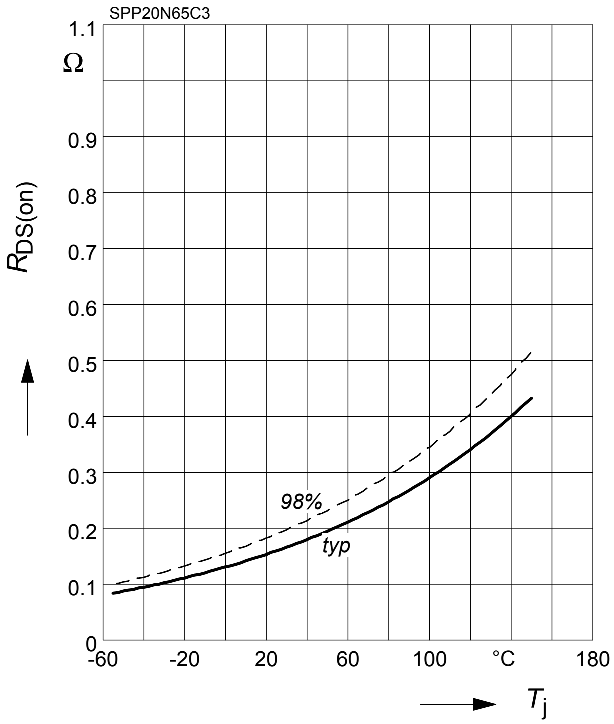
parameter: T_j=150°C, V_{GS}



9 Drain-source on-state resistance

$R_{DS(on)} = f(T_j)$

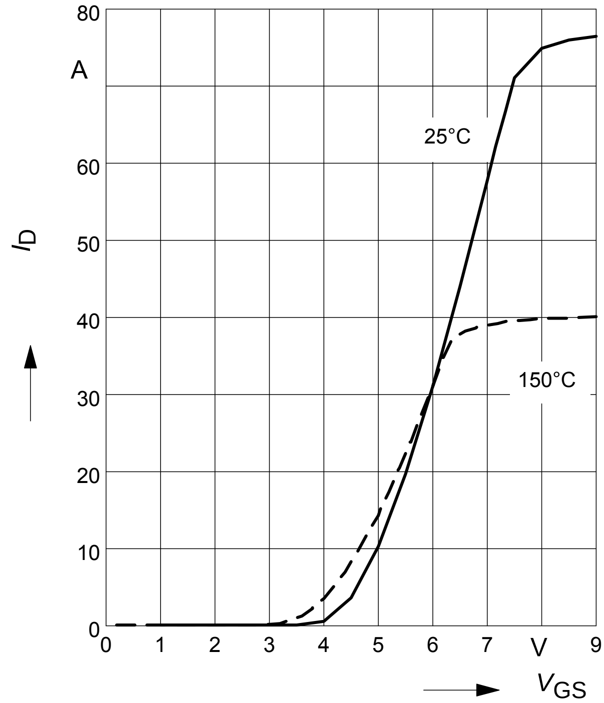
parameter : I_D = 13.1 A, V_{GS} = 10 V



10 Typ. transfer characteristics

$I_D = f(V_{GS})$; $V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$

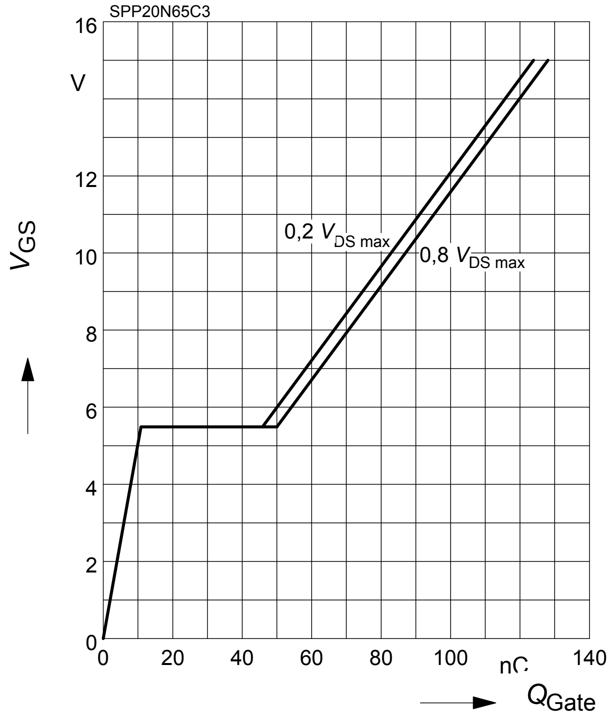
parameter: t_p = 10 µs



11 Typ. gate charge

$V_{GS} = f(Q_{Gate})$

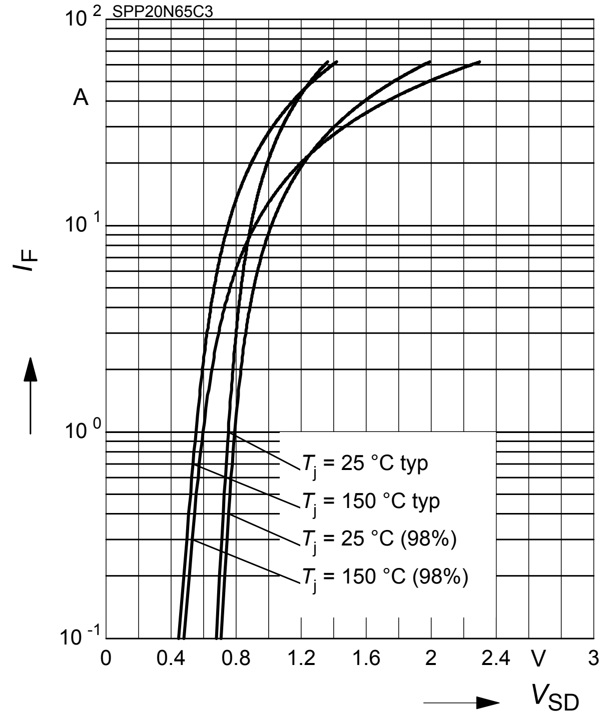
parameter: I_D = 20.7 A pulsed



12 Forward characteristics of body diode

$I_F = f(V_{SD})$

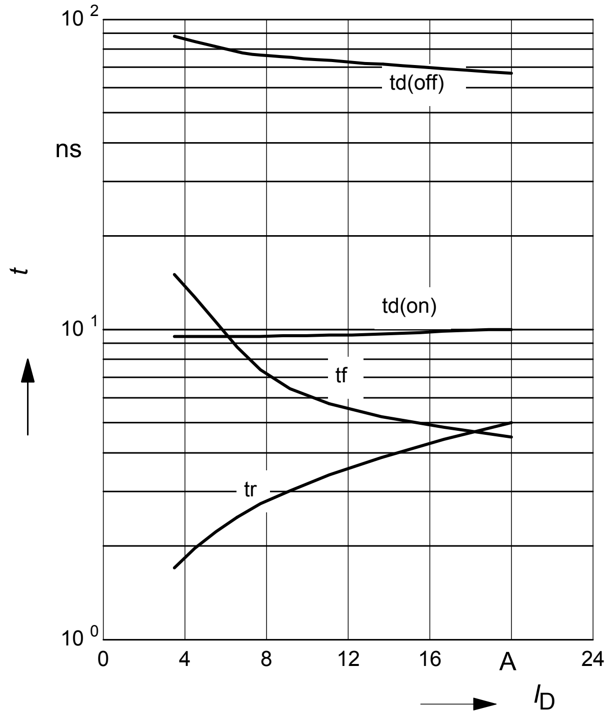
parameter: T_j , tp = 10 µs



13 Typ. switching time

$t = f\,(I_D)$, inductive load, T_j=125°C

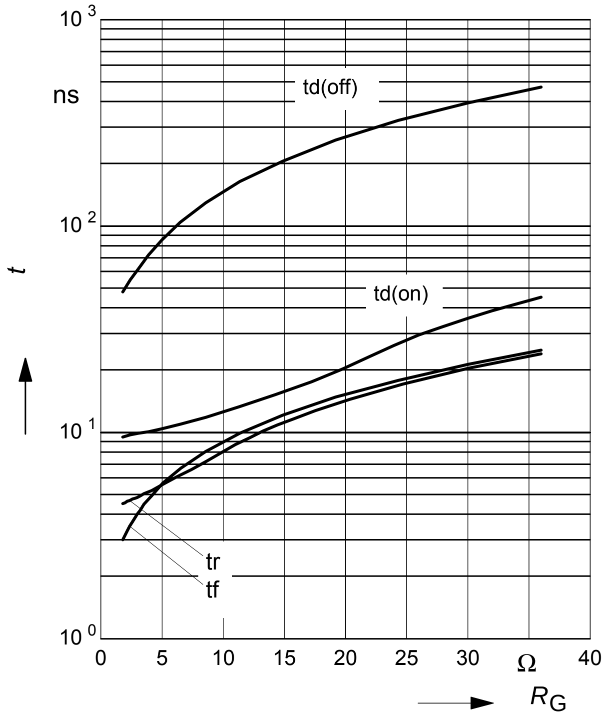
par.: V_{DS}=380V, V_{GS}=0/+13V, R_G=3.6Ω



14 Typ. switching time

$t = f\,(R_G)$, inductive load, T_j=125°C

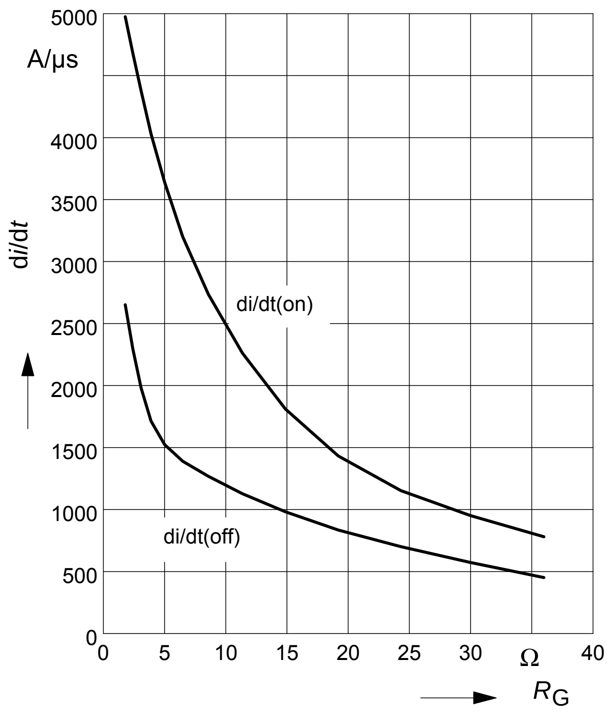
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=20.7 A



15 Typ. drain current slope

di/dt = f(R_G), inductive load, T_j = 125°C

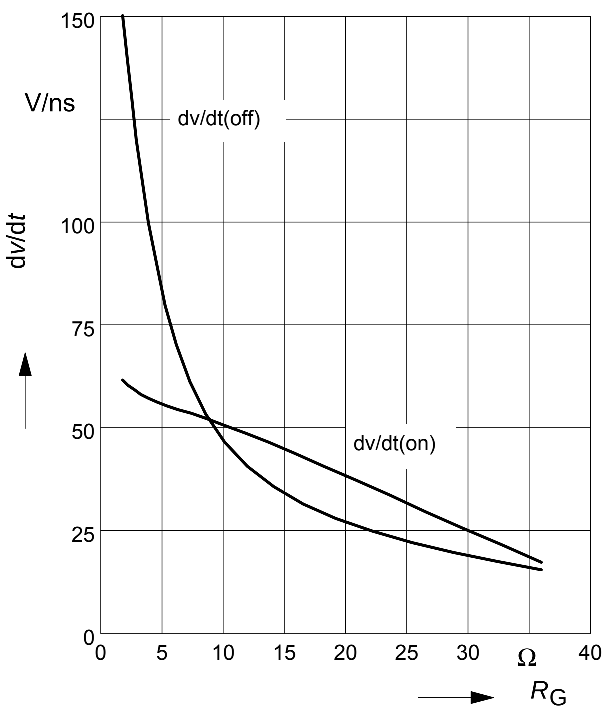
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=20.7A



16 Typ. drain source voltage slope

dv/dt = f(R_G), inductive load, T_j = 125°C

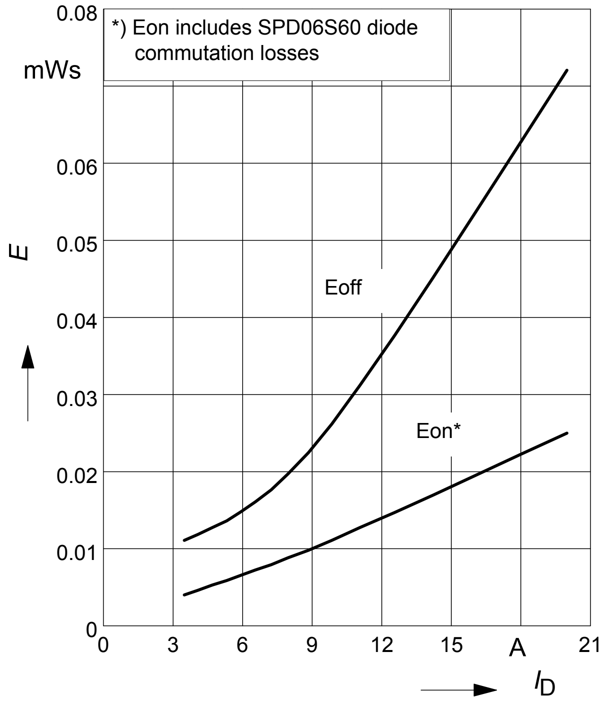
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=20.7A



17 Typ. switching losses

$E = f(I_D)$, inductive load, T_j=125°C

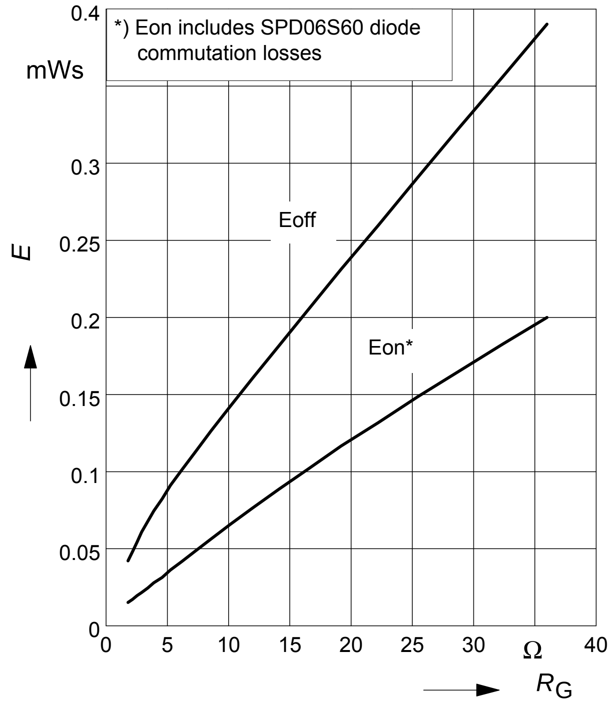
par.: V_{DS}=380V, V_{GS}=0/+13V, R_G=3.6Ω



18 Typ. switching losses

$E = f(R_G)$, inductive load, T_j=125°C

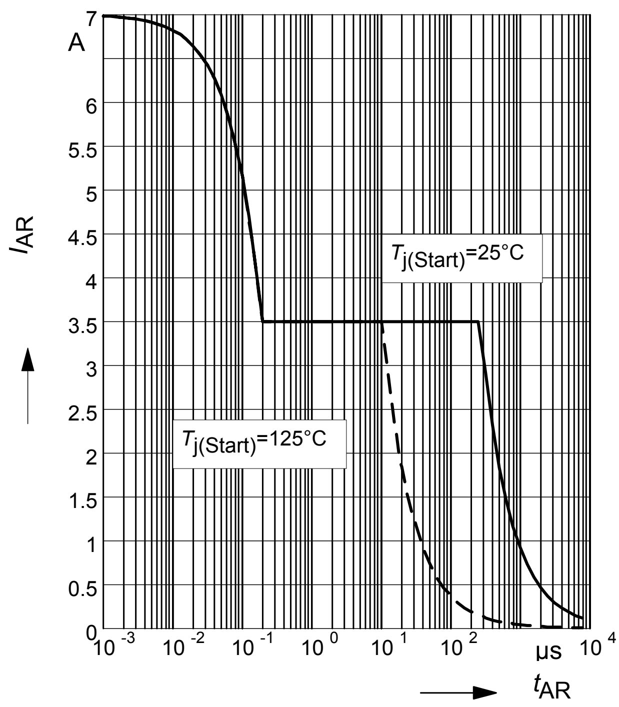
par.: V_{DS}=380V, V_{GS}=0/+13V, I_D=11A



19 Avalanche SOA

$I_{AR} = f(t_{AR})$

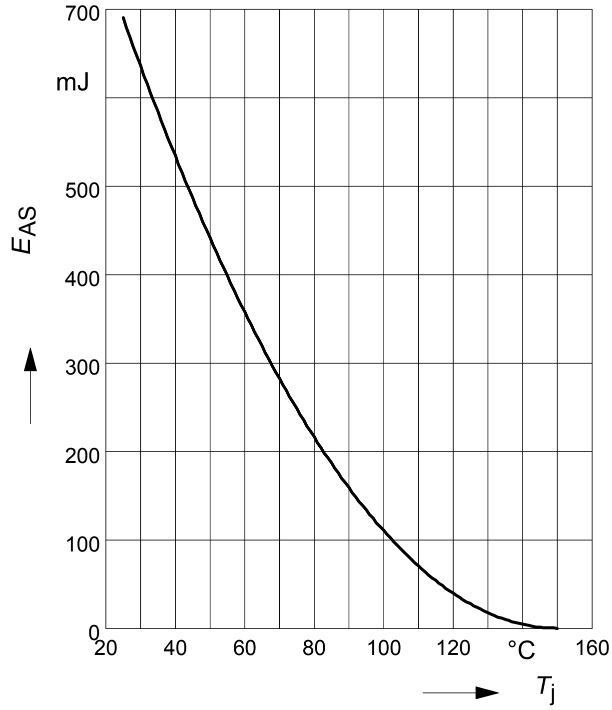
par.: $T_j \leq 150$ °C



20 Avalanche energy

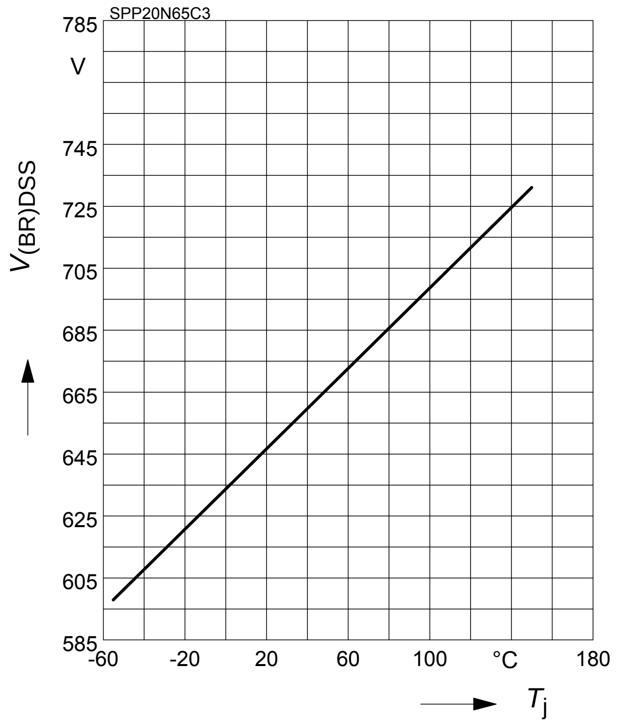
$E_{AS} = f(T_j)$

par.: I_D = 3.5 A, V_{DD} = 50 V



21 Drain-source breakdown voltage

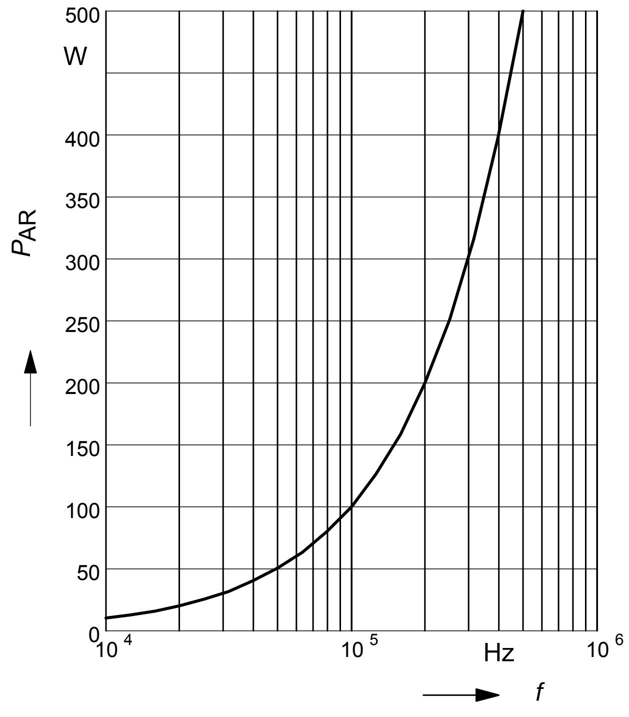
$V_{(BR)DSS} = f(T_j)$



22 Avalanche power losses

$P_{AR} = f(f)$

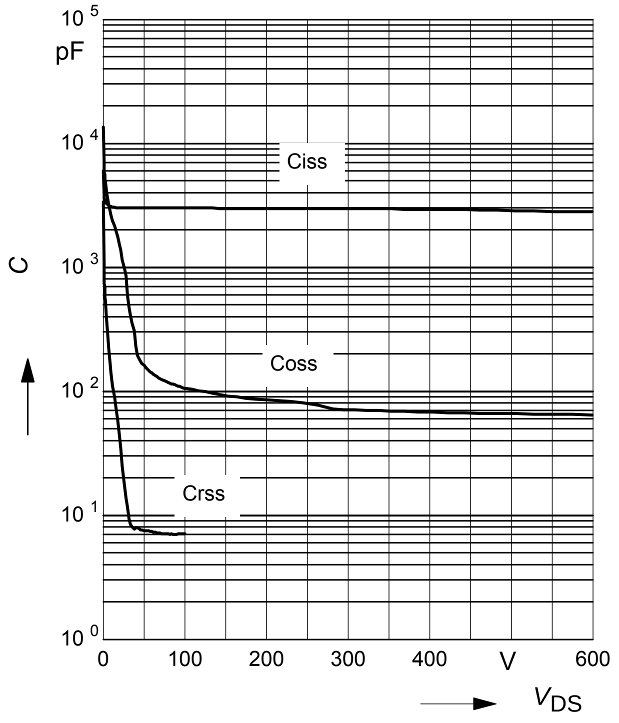
parameter: E_{AR}=1mJ



23 Typ. capacitances

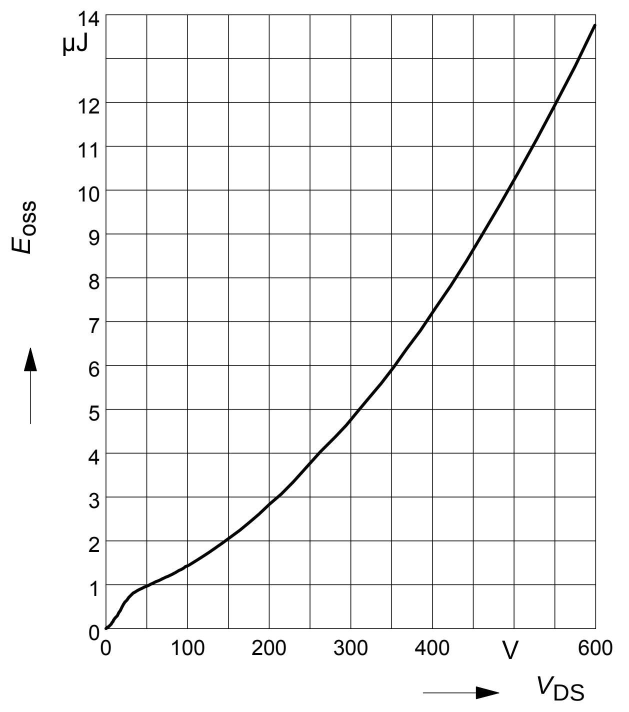
$C = f(V_{DS})$

parameter: V_{GS}=0V, f=1 MHz

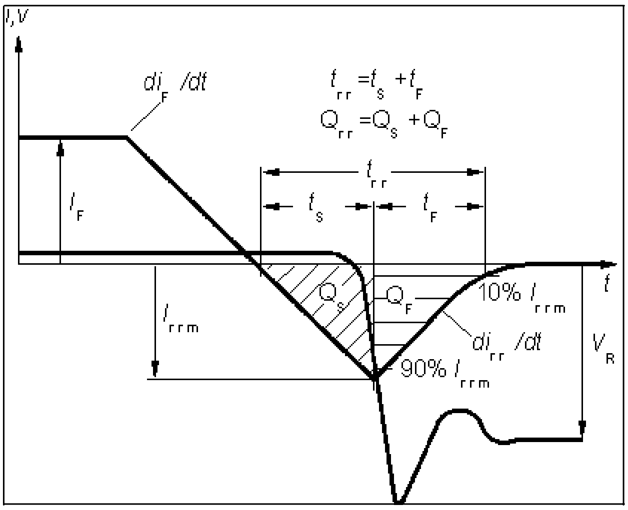


24 Typ. C_{oss} stored energy

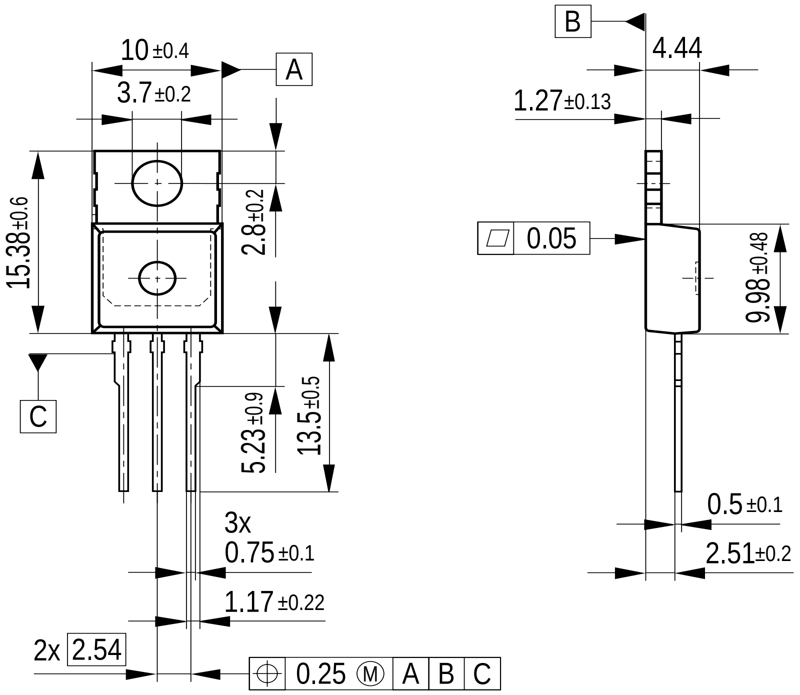
$E_{oss}=f(V_{DS})$



Definition of diodes switching characteristics

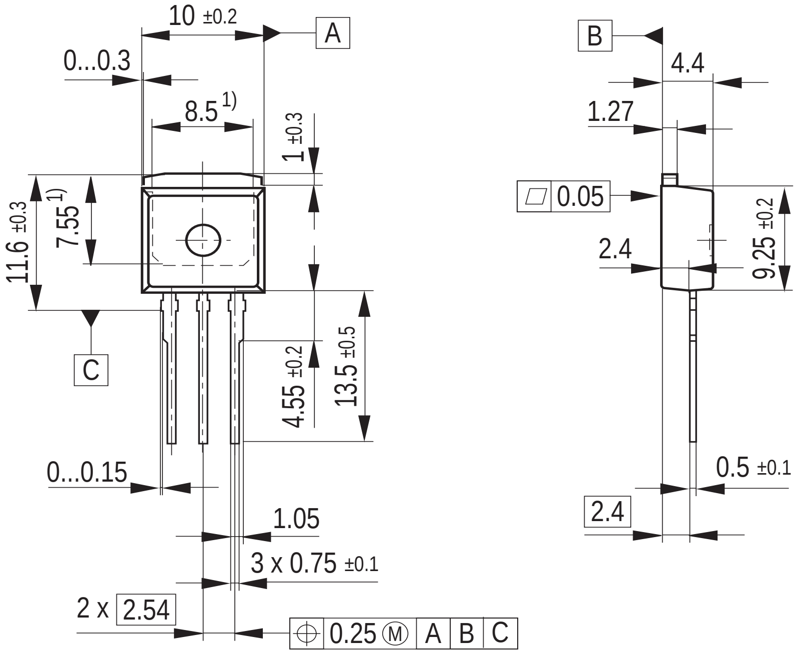


P-TO-220-3-1



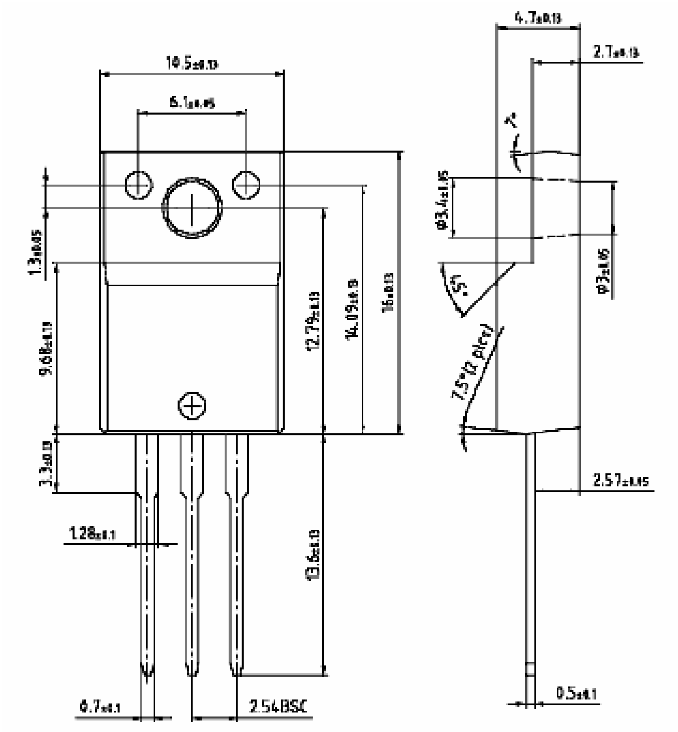
All metal surfaces tin plated, except area of cut.
Metal surface min. x=7.25, y=12.3

P-TO-262-3-1 (I2-PAK)



1) Typical
Metal surface min. X = 7.25, Y = 6.9
All metal surfaces tin plated, except area of cut.

P-TO-220-3-31 (FullPAK)



Please refer to mounting instructions (application note AN-TO220-3-31-01)

Published by
Infineon Technologies AG,
Bereichs Kommunikation
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